Search Notes

Application/Control No	. Applicant(s)/Patent under Reexamination
09/765,411	ISHIZAWA ET AL.
Examiner	Art Unit
Anh T.N. Vo	2861

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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